

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 196124US2		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Kenichi TAKEKAWA ET AL			
		FILING DATE HEREWITH		GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>LS</i>	AA	4,644,100	2-17-87	BRENNER ET AL	—	—	
<i>LS</i>	AB	4,791,416	12-13-88	ADLER	—	—	
	AC						
	AD						
	AE						
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	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
YES	NO						
<i>LS</i>	AO	05-173699	7-13-93	JAPAN (ENGLISH ABSTRACT ONLY)			
<i>LS</i>	AP	09-319501	12-12-97	JAPAN (ENGLISH ABSTRACT ONLY)			
	AQ						
	AR						
	AS						
	AT						
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	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner		<i>ls</i> <i>ls</i>				Date Considered 06.18.02	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 196124US2		SERIAL NO. 09/653,336	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Kenichi TAKEKAWA, et al.					
		FILING DATE August 31, 2000		GROUP 2674			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
LS	AA	4,384,201	05/17/83	Arthur B. CARROLL, et al.	—	—	
	AB						
	AC						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
LS	AO	41 21 180	01/07/93	GERMANY		X	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
LS	AW	Patent Abstracts of Japan, vol. 015, no. 136 (P-1187), April 4, 1991, JP 03-015920, January 24, 1991					
	AX						
	AY						
	AZ						
Examiner	Leon <i>[Signature]</i>				Date Considered 06.17.02		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.